

Application/Control No.	Applicant(s)/Patent under Reexamination
10/757,574	MIZOGUCHI ET AL.
Examiner	Art Unit

2829

Emily Y. Chan

SEARCHED						
Class	Subclass	Date	Examiner			
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
				
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SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
324/761, 750-765 (text searched only - see search history printout)	11/10/2005	EC
Consulted with primary examiner Mr. Vinh P. Nguyen.	11/10/2005	EC
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